

Search Notes

Application/Control No.

10/605,474

Examiner

SARGON N. NANO

Applicant(s)/Patent under
Reexamination

KORTUM ET AL.

Art Unit

2157

SEARCHED

Class	Subclass	Date	Examiner
709	203, 212 217, 220 229, 232	5/10/2008	SN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST SEARCH	5/10/2008	SN
Consulted with primary Meko	5/9/2008	SN